

30V N-ch Power MOSFET

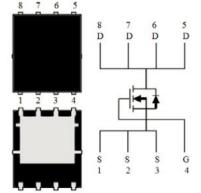
General Features

- Proprietary Advanced Trench Technology
- ightharpoonup R_{DS(ON),typ.}=6.7m Ω @V_{GS}=10V
- Ultra-low Gate Charge Minimize Switching Loss
- Optimized Breakdown Ruggedness

BV _{DSS}	$R_{DS(ON),max.}$	$I_D^{[1]}$
30V	8.8mΩ	15A

Applications

➤ High efficiency Switching



Ordering Information

Part Number	Package	Marking
MXP30N8P8UG	MaxPAK(5x6)	MXP30N8P8UG

Absolute Maximum Ratings

 T_A =25°C unless otherwise specified

Symbol	Parameter	Value	Unit	
V _{DSS}	Drain-to-Source Voltage	30		
V_{GSS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current	15		
I_D	Continuous Drain Current at T _C =25℃	40	A	
	Continuous Drain Current at T _C =100°C	31		
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	60		
E _{AS}	Single Pulse Avalanche Energy (V _{DD} =15V, R _G =25Ω, L=0.1mH)	17	mJ	
	Power Dissipation ^[3]	3.0	10/	
P_{D}	Power Dissipation at T _C =25 [°] C	22	W	
	Derating Factor above 25℃	0.024	W/℃	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	$^{\circ}$ C	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case			5.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient ^[3]			41.7	CIVV



Electrical Characteristics

OFF Characteristics

T_J =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	30			٧	V _{GS} =0V, I _D =1mA
I _{DSS}	Drain-to-Source Leakage Current			1	uA	V _{DS} =24V, V _{GS} =0V
I _{GSS}	Gate-to-Source Leakage Current			±100	nA	V_{GS} =±20V, V_{DS} =0V

ON Characteristics

 T_J =25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
D	Static Drain-to-Source		6.7	8.8	mΩ	V _{GS} =10V, I _D =15A
R _{DS(ON)}	On-Resistance ^[4]		8.8	13.3		V _{GS} =4.5V, I _D =15A
V _{GS(TH)}	Gate Threshold Voltage	1.2		2.5	V	$V_{DS} = V_{GS}$, $I_D = 1 \text{mA}$

Dynamic Characteristics

Essentially independent of operating temperature

					ĺ	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		0.59			V _{GS} =0V,
C _{rss}	Reverse Transfer Capacitance		0.04		nF	V _{DS} =15V,
C _{oss}	Output Capacitance		0.16			f=1.0MH _Z
R_g	Gate Series Resistance		2.3		Ω	f=1.0MH _Z
Q_{q}	Total Gate Charge ^[4]		10.0			V_{DD} =15V, I_{D} =15A, V_{GS} =10V
9	g .		4.8		nC	\
Q_{gs}	Gate-to-Source Charge ^[4]		2.3			V_{DD} =15V, I_{D} =15A, V_{GS} =4.5V
Q_{gd}	Gate-to-Drain (Miller) Charge ^[4]		1.1			1D-10A, VGS-4.5V

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
t _{d(on)}	Turn-on Delay Time ^[4]		9.6			V _{DD} =15V
t _{rise}	Rise Time ^[4]		4.5		ns	I _D =7.5A V _{GS} =10V
t _{d(off)}	Turn-off Delay Time ^[4]		25.5			
t _{fall}	Fall Time ^[4]		3.4			$R_G=10\Omega$

Source-Drain Body Diode Characteristics

T_J=25 °C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
V _{SD}	Diode Forward Voltage ^[4]			1.2	V	I _S =2.5A, V _{GS} =0V
t _{rr}	Reverse Recovery Time ^[4]		21.4		ns	V _{GS} =0V
Q _{rr}	Reverse Recovery Charge ^[4]		11.8		nC	I _S =15A,di/dt=100A/μs

Note:

^[1] T_C =25°C, Limited only by maximum temperature allowed.

^[2] P_W≤10µS, Duty cycle≤1%.

^[3] Mounted on a Cu board (40x40x0.8mm)

^[4] Pulsed



Typical Characteristics

Fig.1 Power Dissipation Derating Curve

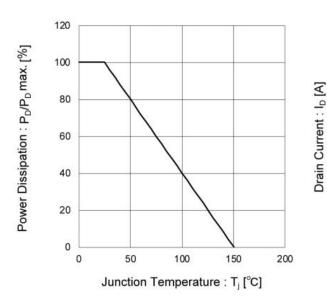


Fig.2 Maximum Safe Operating Area

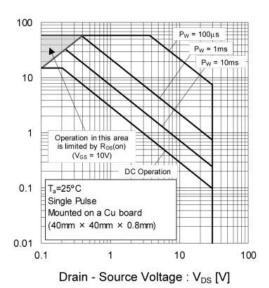


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

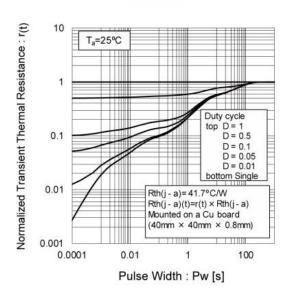


Fig.4 Single Pulse Maximum Power dissipation

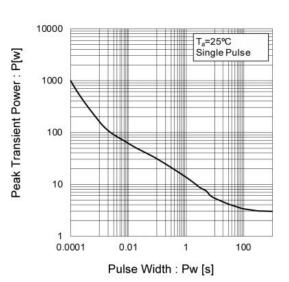




Fig.5 Typical Output Characteristics(I)

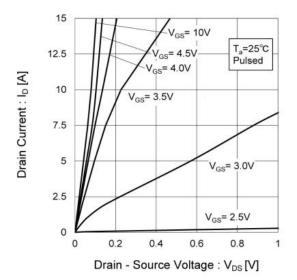


Fig.6 Typical Output Characteristics(II)

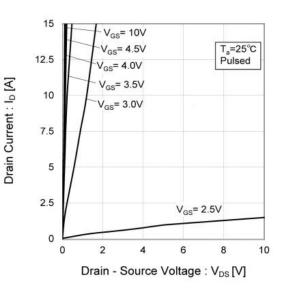


Fig.7 Breakdown Voltage vs.
Junction Temperature

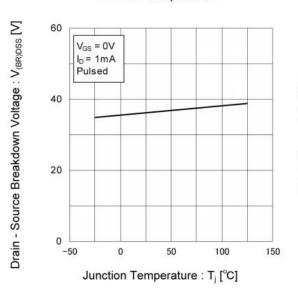
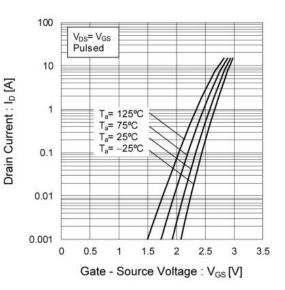


Fig.8 Typical Transfer Characteristics





Gate Threshold Voltage: VGS(th) [V]

Fig.9 Gate Threshold Voltage vs. Junction Temperature

V_{DS} = V_{GS}
I_D = 1mA
Pulsed

2

1

Junction Temperature : T_j [°C]

Fig.10 Forward Transfer Admittance vs.

Drain Current

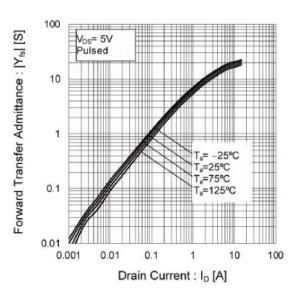


Fig.11 Drain Current Derating Curve

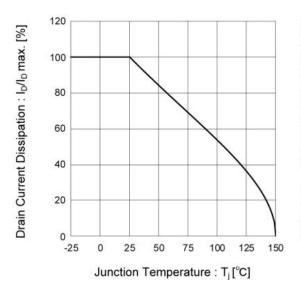


Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

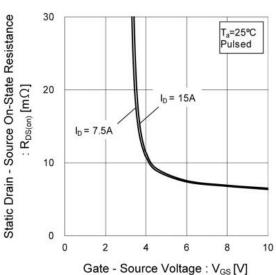




Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature

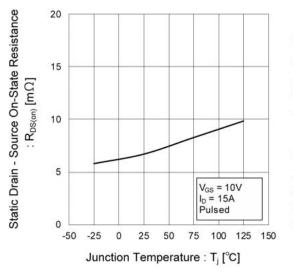


Fig.14 Static Drain - Source On - State Resistance vs. Drain Current (I)

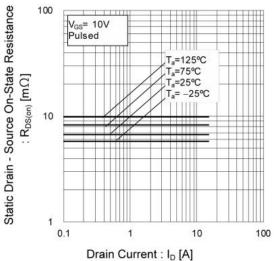


Fig.15 Static Drain - Source On - State Resistance vs. Drain Current (II)

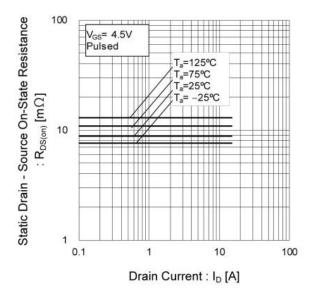




Fig.16 Typical Capacitance vs.

Drain - Source Voltage

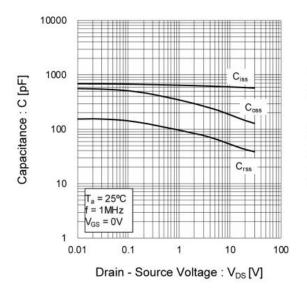


Fig.17 Switching Characteristics

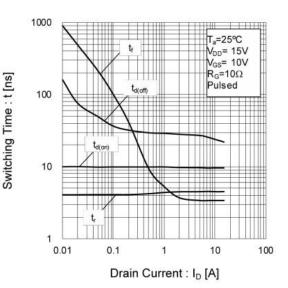


Fig.18 Dynamic Input Characteristics

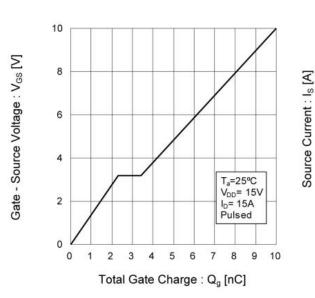
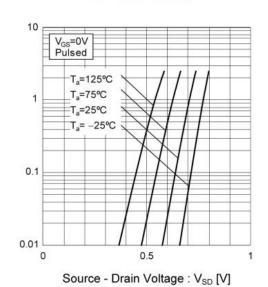


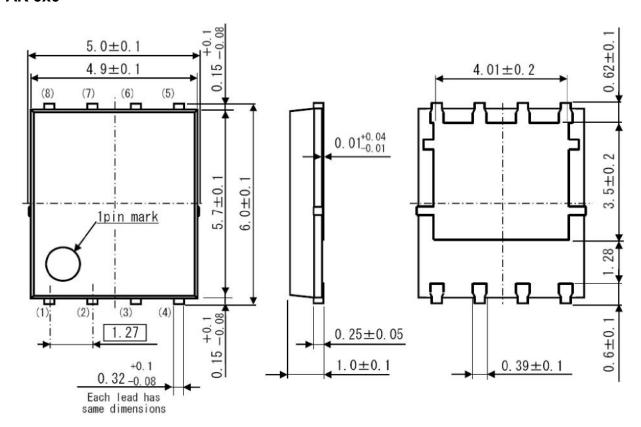
Fig.19 Source Current vs.
Source Drain Voltage

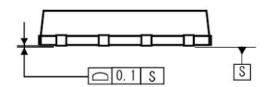




Package Dimensions

MaxPAK 5x6





UNIT:mm



Disclaimers:

MaxPower Semiconductor Inc. (MXP) reserves the right to make changes without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to MXP's terms and conditions supplied at the time of order acknowledgement.

MaxPower Semiconductor Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf, disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

MaxPower Semiconductor Inc. disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify MXP's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

MaxPower Semiconductor Inc. warrants performance of its hardware products to the specifications at the time of sale, testing, reliability and quality control are used to the extent MXP deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessarily performed.

MaxPower Semiconductor Inc. does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using MXP's components. To minimize risk, customers must provide adequate design and operating safeguards.

MaxPower Semiconductor Inc. does not warrant or convey any license to any intellectual property rights either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in MXP's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice.

MaxPower Semiconductor Inc. is not responsible or liable for such altered documentation. Resale of MXP's products with statements different from or beyond the parameters stated by MaxPower Semiconductor Inc. for that product or service voids all express or implied warrantees for the associated MXP product or service and is an unfair and deceptive business practice.

MaxPower Semiconductor Inc. is not responsible or liable for any such statements.

Published by MaxPower Semiconductor Inc. 181 Metro Dr, Suite 590, San Jose, CA 95110

All Rights Reserved.